

**Search Notes**

Application/Control No.

09/834,165

Examiner

Yogesh K. Aggarwal

Applicant(s)/Patent under  
Reexamination

TANAKA ET AL.

Art Unit

2615

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
used the same references		